S	eai	ch	No	te	S



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,564	CHANG ET AL.	
Examiner	Art Unit	
Christopher Onuaku	2621	

,			<del></del>
SEARCHED			
Class	Subclass	Date	Examiner
386	27,33,46,6 1,66,71,95 ,96,104,	8/7/2007	coo
	105,109,		t .
	111,112		
	119,124		
	125,126		
725	81,82	8/7/2007	coo
348	448,564	8/7/2007	coo
	557,515		
	512,513		
•			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	_		

SE. (INCLUDING	ARCH NOT		) .
		DATE	EXMR
Huy Nguyen 386		8/7/2007	coo
Huy Nguyen 725		8/7/2007	coo
Michael Lee 348		8/7/2007	coo
	1		
	1	·	